

**Search Notes**

Application/Control No.

10/747,983

Examiner

John T. Kwon

Applicant(s)/Patent under  
Reexamination

WAYAMA ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	337	9/8/2005	JK
	360		
	361		
	376		
	399		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	9/8/2005	JK